

<b>Search Notes</b> 				<b>Application/Control No.</b> 10/644,211 <b>Examiner</b> Anh Q. Tran		<b>Applicant(s)/Patent and Reexamination</b> <b>BROWN ET AL.</b> <b>Art Unit</b> 2819	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>			
Class	Subclass	Date	Examiner			DATE	EXMR
326	17 33	1/28/05	AT				
	112						
	119						
	121						
<b>INTERFERENCE SEARCHED</b>							
Class	Subclass	Date	Examiner				